

Issue Classification		Application/Control No.	Applicant(s)/Patent under Reexamination	
		10/764,734	CHANG, AO YU	
Examiner		Art Unit		
Bena Miller		3725		

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
144	333	144	346	348	350	364	380	
INTERNATIONAL CLASSIFICATION		52	730.1					
B	2	7	J	7/00	156	250	296	
				428	106			
<i>(Assistant Examiner)</i> <i>(Date)</i>		<i>Bena B. Miller</i> BENA MILLER PRIMARY EXAMINER (Lead Instruments Examiner) <i>(Date)</i>						
<i>(Legal Instruments Examiner)</i> <i>(Date)</i>		<i>09/29/05</i>						
Total Claims Allowed: 4								
<input type="checkbox"/> O.G. Print Claim(s)					<input type="checkbox"/> O.G. Print Fig.			
1					1			

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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29	26	59		89		119	
30	27	60		90		120	